

7N80H-VB TO220 Datasheet **Power MOSFET**

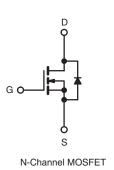
PRODUCT SUMMARY						
V _{DS} (V)	850	850				
R _{DS(on)} (Ω)	V _{GS} = 10 V	1.7				
Q _g (Max.) (nC)	130					
Q _{gs} (nC)	17					
Q _{gd} (nC)	72					
Configuration	Single					

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- Isolated central mounting hole
- · Fast switching
- · Ease of paralleling
- Simple drive requirements







ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise PARAMETER			SYMBOL LIMIT		UNIT	
Drain-Source Voltage			V _{DS}	850	.,	
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25^{\circ}$	T _C = 25 °C	- I _D	6.0	А	
	V _{GS} at 10 V	T _C = 100 °C		4.2		
Pulsed Drain Current ^a			I _{DM}	24		
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	490	mJ	
Repetitive Avalanche Current a			I _{AR}	5.4	А	
Repetitive Avalanche Energy a			E _{AR}	15	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150		
Soldering Recommendations (Peak Temperature) ^d	for 10 s		-	300	°C	
Mounting Torque	6.00	140		10	lbf ⋅ in	
	6-32 or M3 screw			1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 31 \,^{\circ}\text{mH}$, $R_g = 25 \,^{\circ}\text{C}$, $I_{AS} = 5.4 \,^{\circ}\text{A}$ (see fig. 12). c. $I_{SD} \le 5.4 \,^{\circ}\text{A}$, $I_{AS} = 120 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	40			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83			

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static					ļ.	ļ	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		850	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I _D = 1 mA		0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	V _{DS} = V _{GS} , I _D = 250 μA		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 850 V, V _{GS} = 0 V V _{DS} = 680 V, V _{GS} = 0 V, T _J = 125 °C		-	100 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.2 A ^b		1.7	-	Ω
Forward Transconductance	9 _{fs}		00 V, I _D = 3.2 A ^b	3.0		-	S
Dynamic		_			L		
Input Capacitance	C _{iss}	V	_{GS} = 0 V,	-	1900	-	pF
Output Capacitance	C _{oss}		_{OS} = 25 V,	-	470	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0	MHz, see fig. 5	-	280	-	
Total Gate Charge	Qg			-	-	130	
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 5.4 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 b	-	-	17	nC
Gate-Drain Charge	Q _{gd}	1	See lig. 0 and 15	-	-	72	
Turn-On Delay Time	t _{d(on)}			-	16	-	
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_D = 5.4 \text{ A},$ $R_g = 9.1 \Omega, R_D = 75 \Omega, \text{ see fig. } 10^{\text{ b}}$		-	36	-	ns
Turn-Off Delay Time	t _{d(off)}			-	100	-	
Fall Time	t _f			-	32	-	
Internal Drain Inductance	L _D	Between lead,	Between lead.		5.0	-	
Internal Source Inductance	L _S	6 mm (0.25") from package and center of die contact		-	13	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	IS	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.4	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	22	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S	$_{S} = 5.4 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 ^{\circ}\text{C}, I_{F} = 5.4 \text{A}, \text{dl/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	550	830	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.4	3.6	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	on time is negligible (turn	-on is do	ninated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

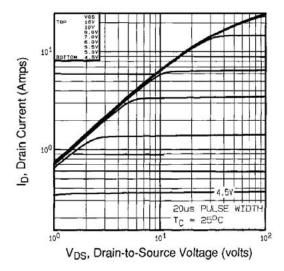


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

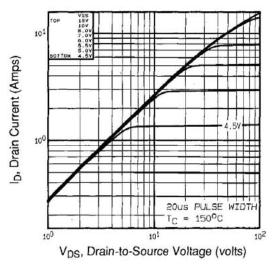


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

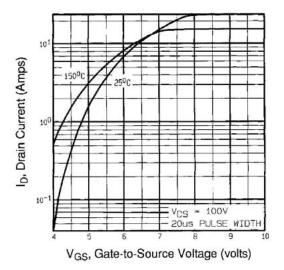


Fig. 3 - Typical Transfer Characteristics

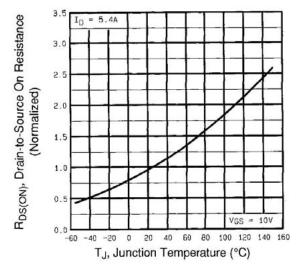


Fig. 4 - Normalized On-Resistance vs. Temperature



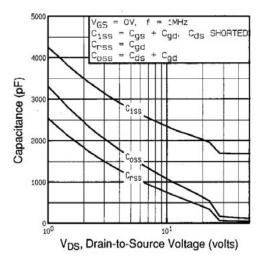


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

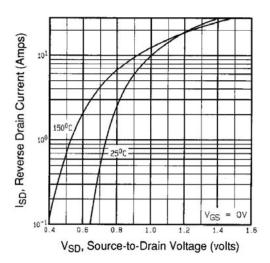


Fig. 7 - Typical Source-Drain Diode Forward Voltage

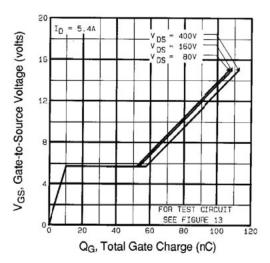


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

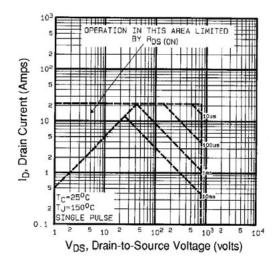


Fig. 8 - Maximum Safe Operating Area



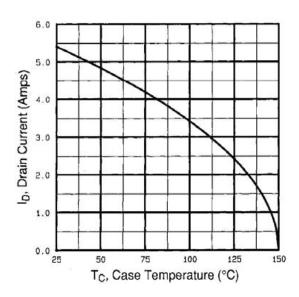


Fig. 9 - Maximum Drain Current vs. Case Temperature

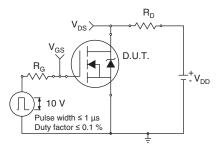


Fig. 10a - Switching Time Test Circuit

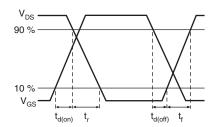


Fig. 10b - Switching Time Waveforms

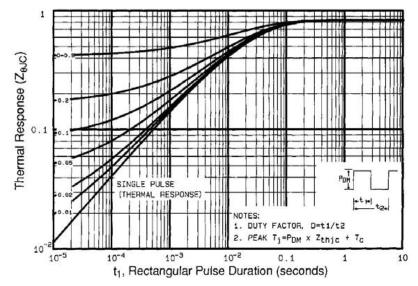
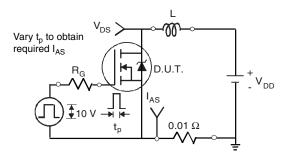
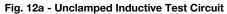


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







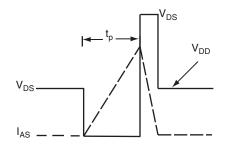


Fig. 12b - Unclamped Inductive Waveforms

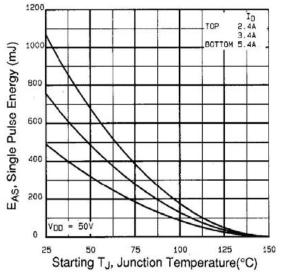


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

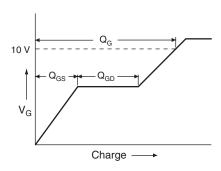


Fig. 13a - Basic Gate Charge Waveform

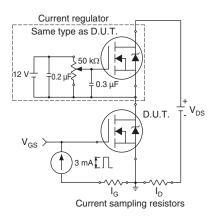
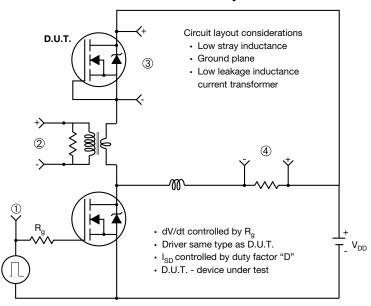


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



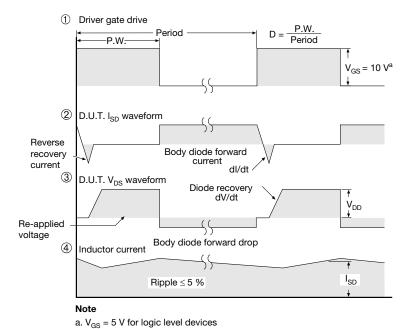
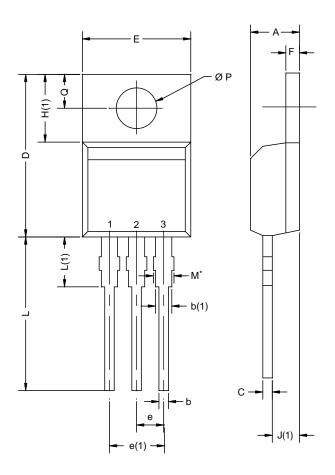


Fig. 14 - For N-Channel



TO-220AB



	MILLIM	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
Е	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12					

DWG: 5471

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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